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<ul> <li>Output Ports Have Equivalent 25-Ω Series</li></ul>	SN54ABT162827 WD PACKAGE				
Resistors, So No External Resistors Are	SN74ABT162827 DGG OR DL PACKAGE				
Required	(TOP VIEW)				
<ul> <li>Members of the Texas Instruments</li></ul>	10E1 1 56 10E2				
Widebus <sup>™</sup> Family	1Y1 2 55 1A1				
<ul> <li>State-of-the-Art EPIC-IIB<sup>™</sup> BiCMOS Design</li></ul>	1Y2 [ 3 54 ] 1A2				
Significantly Reduces Power Dissipation	GND [ 4 53 ] GND				
<ul> <li>Latch-Up Performance Exceeds 500 mA</li></ul>	1Y3 [ 5 52 ] 1A3				
Per JEDEC Standard JESD-17	1Y4 [ 6 51 ] A14				
<ul> <li>Typical V<sub>OLP</sub> (Output Ground Bounce)</li> <li>&lt; 1 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C</li> </ul>	V <sub>CC</sub> [7 50 ] V <sub>CC</sub> 1Y5 [8 49] 1A5				
<ul> <li>Distributed V<sub>CC</sub> and GND Pin Configuration Minimizes High-Speed Switching Noise</li> </ul>	1Y6 9 48 1A6 1Y7 10 47 1A7 GND 11 46 GND				
<ul> <li>Flow-Through Architecture Optimizes</li></ul>	1Y8 [ 12 45 ] 1A8				
PCB Layout	1Y9 [ 13 44 ] 1A9				
<ul> <li>Package Options Include Plastic 300-mil</li></ul>	1Y10 [ 14 43 ] 1A10				
Shrink Small-Outline (DL) and Thin Shrink	2Y1 [ 15 42 ] 2A1				
Small-Outline (DGG) Packages and 380-mil	2Y2 [ 16 41 ] 2A2				
Fine-Pitch Ceramic Flat (WD) Package	2Y3 [ 17 40 ] 2A3				
Using 25-mil Center-to-Center Spacings	GND [ 18 39 ] GND				
description	2Y4 [ 19 38 ] 2A4				
The 'ABT162827 are noninverting 20-bit buffers	2Y5 20 37 2A5 2Y6 21 36 2A6				
composed of two 10-bit buffers with separate output-enable signals. For either 10-bit buffer, the	V <sub>CC</sub> [ 22 35 ] V <sub>CC</sub> 2Y7 [ 23 34 ] 2A7				
two output-enable $(1\overline{OE1} \text{ and } 1\overline{OE2} \text{ or } 2\overline{OE1} \text{ and } 2\overline{OE2})$ inputs must both be low for the	2Y8 24 33 2A8 GND 25 32 GND				
corresponding Y outputs to be active. If either	2Y9 26 31 2A9				

The outputs, which are designed to source or sink up to 12 mA, include  $25-\Omega$  series resistors to reduce overshoot and undershoot.

output-enable input is high, the outputs of that 10-bit buffer are in the high-impedance state.

To ensure the high-impedance state during power up or power down, OE inputs should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74ABT162827 is available in TI's shrink small-outline package (DL), which provides twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

The SN54ABT162827 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ABT162827 is characterized for operation from -40°C to 85°C.

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30 2A10

20E2

29

2Y10 🛛 27

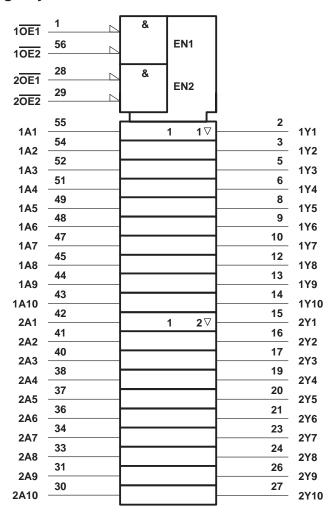
20E1

28

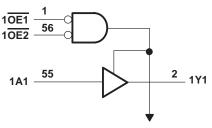
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FUNCTION TABLE (each 10-bit buffer)							
	INPUTS	OUTPUT					
OE1	OE2	Α	Y				
L	L	L	L				
L	L	Н	Н				
Н	Х	Х	Z				
Х	Н	Х	Z				

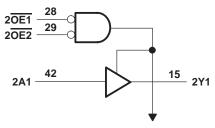
### logic symbol<sup>†</sup>



### logic diagram (positive logic)



**To Nine Other Channels** 



**To Nine Other Channels** 

<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Storage temperature range	Supply voltage range, $V_{CC}$ Input voltage range, $V_I$ (see Note 1) Voltage range applied to any output in the hid Current into any output in the low state, $I_O$ Input clamp current, $I_{IK}$ ( $V_I < 0$ ) Output clamp current, $I_{OK}$ ( $V_O < 0$ ) Maximum power dissipation at $T_A = 55^{\circ}C$ (in Operating free-air temperature range, $T_A$ : S	igh state or power-off state, V <sub>O</sub> n still air) (see Note 2): DGG package DL package SN54ABT162827	-0.5 V to 7 V -0.5 V to 5.5 V 
	S	SN74ABT162827	40°C to 85°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the Package Thermal Considerations application note in the 1994 ABT Advanced BiCMOS Technology Data Book. literature number SCBD002B.

#### recommended operating conditions (see Note 3)

			SN54ABT162827		SN74ABT162827		
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		4.5	5.5	4.5	5.5	V
VIH	High-level input voltage		2	~	2		V
VIL	Low-level input voltage		0.8		0.8	V	
VI	Input voltage	0	Vcc	0	VCC	V	
IOH	High-level output current		<b>Q</b> –12		-12	mA	
IOL	Low-level output current		NC NC	12		12	mA
	hanned the second from the second at the second	Control inputs	00	9		9	
$\Delta t / \Delta V$	Input transition rise or fall rate	Data inputs	A.	10		10	ns/V
$\Delta t / \Delta V_{CC}$	Power-up ramp rate		200		200		μs/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: Unused or floating inputs must be held high or low.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		Т	A = 25°0	;	SN54AB	T162827	SN74ABT162827		
		TEST CO	MIN	TYP†	MAX	MIN	MAX	MIN	MAX	UNIT	
VIK		V <sub>CC</sub> = 4.5 V,			-1.2		-1.2		-1.2	V	
		V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = – 1 mA	2.5			2.5		2.5		
.,		V <sub>CC</sub> = 5 V,	I <sub>OH</sub> = – 1 mA	3			3		3		
VOH			I <sub>OH</sub> = – 3 mA	2.4			2.4		2.4		V
		V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = - 12 mA	2			2		2		
			I <sub>OL</sub> = 8 mA		0.4	0.8		0.8		0.65	
VOL		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 12 mA							0.8	V
I		$V_{CC} = 0$ to 5.5 V V <sub>I</sub> = V <sub>CC</sub> or GNE				±1		±1		±1	μΑ
IOZPU		$V_{CC} = 0 \text{ to } 2.1 \text{ V},$ $V_{O} = 0.5 \text{ V to } 2.7 \text{ V},  \overline{\text{OE}} = X$				±50		±50		±50	μA
IOZPD		$V_{CC} = 2.1 \text{ V to 0},$ $V_{O} = 0.5 \text{ V to 2.7 V},  \overline{OE} = X$				±50		±50		±50	μA
Iоzн‡		$V_{CC} = 2.1 \text{ V to 5.5 V}, \\ V_{O} = 2.7 \text{ V}, \qquad \overline{\text{OE}} \ge 2 \text{ V}$				10		10		10	μA
I <sub>OZL</sub> ‡		$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V},$ $V_{O} = 0.5 \text{ V}, \qquad \overline{\text{OE}} \ge 2 \text{ V}$				-10	Un.	-10		-10	μA
loff		$V_{CC} = 0,$	VI or VO $\leq$ 4.5 V			±100	00			±100	μA
ICEX	Outputs high	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 5.5 V			50	d'	50		50	μΑ
IO§		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.5 V	-25	-75	-100	-25	-100	-25	-100	mA
	Outputs high					2		2		2	
	Outputs low	V <sub>CC</sub> = 5.5 V,	l <sub>O</sub> = 0,			32		32		32	mA
lcc	Outputs disabled	$V_{I} = V_{CC} \text{ or } GNE$	)			2		2		2	
	V <sub>CC</sub> = 5.5 V, One input at	One input at	Outputs enabled			1		1.5		1	
∆I <sub>CC</sub> ¶	3.4 V, Other inputs at V <sub>CC</sub> or GND	Outputs disabled			0.05		1		0.05	mA	
	Control inputs	V <sub>CC</sub> = 5.5 V, Other inputs at V	One input at 3.4 V, <sub>CC</sub> or GND			1.5		1.5		1.5	
C <sub>i</sub> V <sub>I</sub> = 2.5 V or 0.5 V			3.5						pF		
Co		V <sub>O</sub> = 2.5 V or 0.5	5 V		8						pF

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V.

<sup>‡</sup> The parameters  $I_{OZH}$  and  $I_{OZL}$  include the input leakage current.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

I This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.

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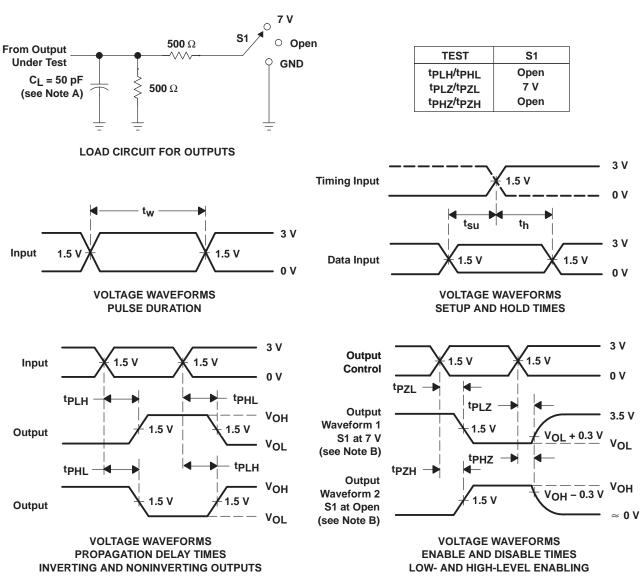
switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50 \text{ pF}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO		V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C		SN54ABT162827		SN74ABT162827		UNIT	
	(INPUT)	(OUTPUT)	MIN	TYP†	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> PLH		V	1	2.1	3.6	1	4.1	1	3.9	
<sup>t</sup> PHL	A	Y	1.1	2.8	4.2	1.1	5	1.1	4.7	ns
<sup>t</sup> PZH	OE	Y	1.5	3.4	6.3	1.5	7.2	1.5	6.9	
<sup>t</sup> PZL	OE	Y	1.6	3.5	7.3	1.6	6.6	1.6	6.3	ns
<sup>t</sup> PHZ	OE	v	2.1	4.1	6.5	2.1	6.8	2.1	6.6	200
<sup>t</sup> PLZ	OE	T	1.5	3.5	5.9	1.5	7.3	1.5	6.3	ns

<sup>†</sup> All typical values are at  $V_{CC}$  = 5 V.



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
   Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.

D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74ABT162827DGGR	OBSOLETE	TSSOP	DGG	56	TBD	Call TI	Call TI
SN74ABT162827DL	OBSOLETE	SSOP	DL	56	TBD	Call TI	Call TI
SN74ABT162827DLR	OBSOLETE	SSOP	DL	56	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# **MECHANICAL DATA**

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

#### DGG (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE

**48 PINS SHOWN** 



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153

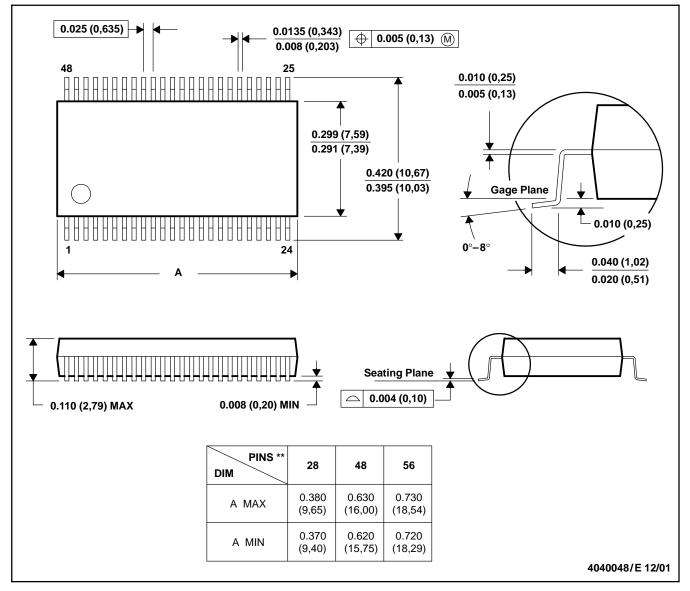


# **MECHANICAL DATA**

MSSO001C - JANUARY 1995 - REVISED DECEMBER 2001

#### PLASTIC SMALL-OUTLINE PACKAGE

DL (R-PDSO-G\*\*) 48 PINS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118



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